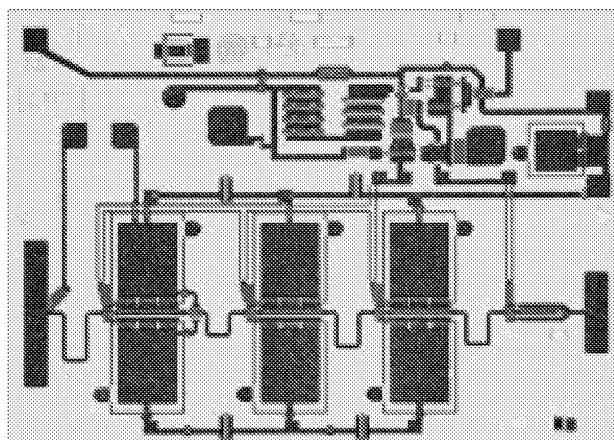


- DC to 18-GHz Frequency Range
- On-Chip Driver Compatible with CMOS or Open-Collector TTL
- Typical Insertion Loss 2.3-dB at 18-GHz
- 1.5:1 Input/Output SWR
- High Isolation; 43-dB Across Band
- 2,489 x 1,803 x 0,102 mm (0.098 x 0.071 x 0.004 in.)

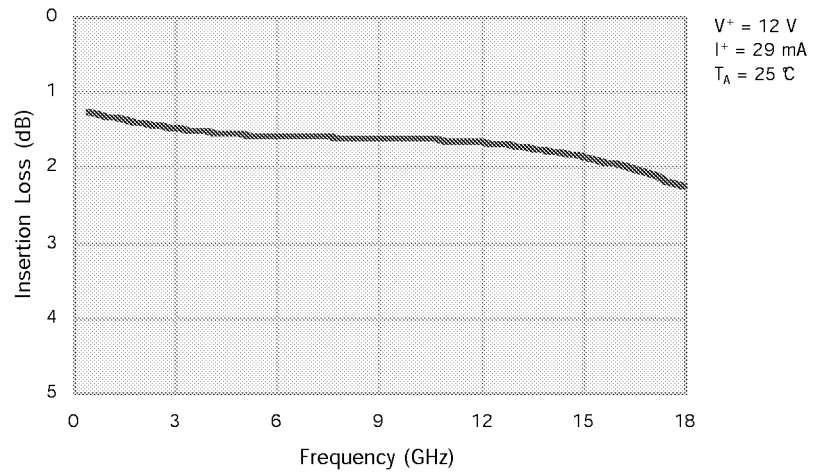
PHOTO ENLARGEMENT**DESCRIPTION**

The Texas Instruments TGS8632-XCC is a GaAs single-pole, single-throw (SPST) monolithic switch which operates over the DC to 18-GHz frequency range. This switch maintains 43-dB isolation and has an on-chip driver compatible with CMOS or open-collector TTL. The driver also provides a complementary output. Input and output return loss is greater than 15-dB. Input power at 1-dB gain compression is typically 25-dBm. Ground is provided to the circuitry through vias to the backside metallization.

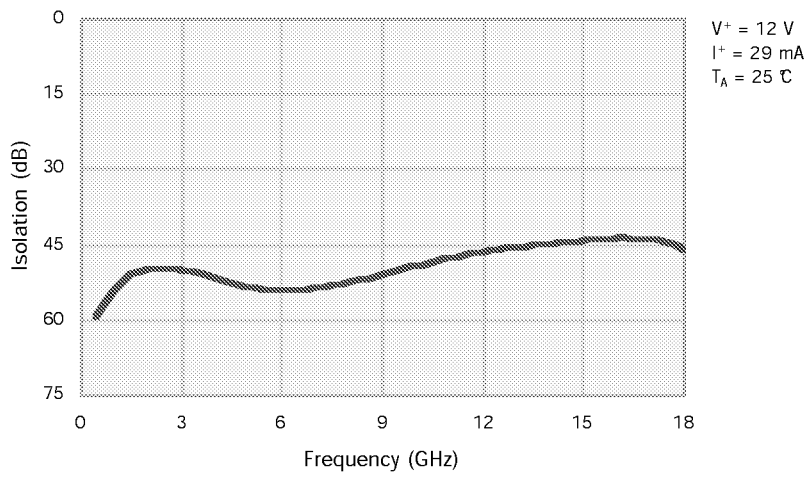
The TGS8632-XCC is suitable for a variety of wide-band applications such as radar systems and communication systems.

Bond pad and backside metallization is gold-plated for compatibility with eutectic alloy attachment methods as well as the thermocompression and thermosonic wire-bonding processes. The TGS8632-XCC is supplied in chip form and is readily assembled using automated equipment.

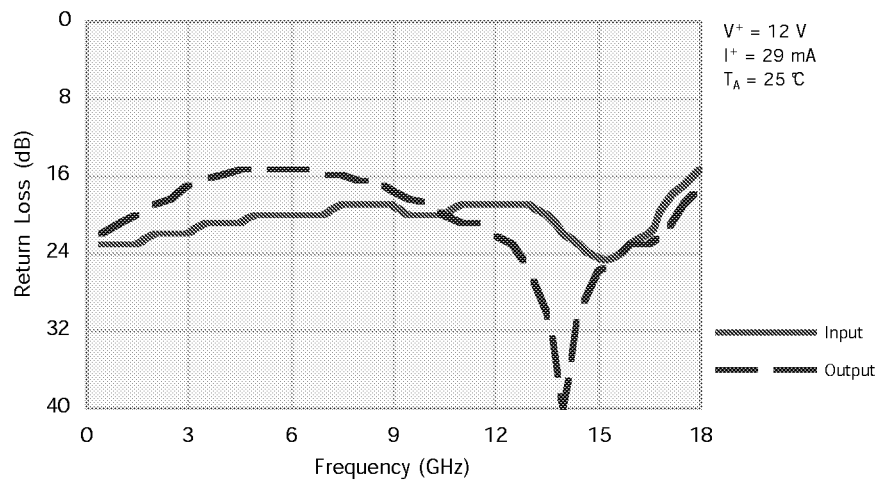
**TYPICAL
INSERTION LOSS**

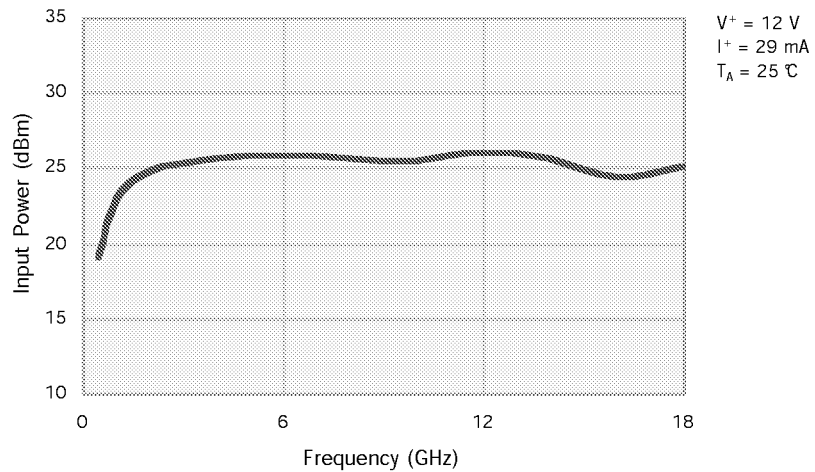


**TYPICAL
ISOLATION**



**TYPICAL
RETURN LOSS**



**TYPICAL
INPUT POWER** P_{1dB} **ABSOLUTE
MAXIMUM RATINGS**

Supply voltage, V^+	15 V
Control voltage range, V_{CTRL}	-10 V to +10 V
Power dissipation, P_D	0.36 W
Input continuous wave power, P_{IN}	1 W
Operating channel temperature, T_{CH}^*	150 °C
Mounting temperature (30 sec), T_M	320 °C
Storage temperature range, T_{STG}	-65 to 150 °C

Ratings over channel temperature range, T_{CH} (unless otherwise noted)

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "RF Characteristics" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

* Operating channel temperature will directly affect the device MTTF. For maximum life, it is recommended that channel temperature be maintained at the lowest possible level.

TYPICAL S-PARAMETERS
 Through Path

Frequency (GHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂		Insertion Loss (dB)
	MAG	ANG(°)	MAG	ANG(°)	MAG	ANG(°)	MAG	ANG(°)	
0.5	0.07	-7	0.86	-8	0.862	-8	0.08	5	1.3
1.0	0.07	-10	0.86	-15	0.857	-15	0.09	8	1.3
1.5	0.07	-14	0.85	-22	0.853	-22	0.10	10	1.4
2.0	0.08	-17	0.85	-29	0.850	-29	0.11	11	1.4
2.5	0.08	-20	0.85	-36	0.846	-36	0.12	10	1.4
3.0	0.08	-24	0.84	-43	0.843	-43	0.14	10	1.5
3.5	0.09	-30	0.84	-50	0.841	-50	0.15	10	1.5
4.0	0.09	-38	0.84	-57	0.837	-57	0.16	9	1.6
4.5	0.09	-48	0.83	-64	0.834	-64	0.17	8	1.6
5.0	0.10	-60	0.83	-71	0.832	-71	0.17	6	1.6
5.5	0.10	-72	0.83	-78	0.832	-78	0.17	4	1.6
6.0	0.10	-83	0.83	-85	0.833	-85	0.17	1	1.6
6.5	0.10	-94	0.83	-92	0.832	-92	0.17	-2	1.6
7.0	0.10	-105	0.83	-99	0.831	-99	0.16	-5	1.6
7.5	0.11	-114	0.83	-106	0.832	-106	0.16	-9	1.6
8.0	0.11	-129	0.83	-113	0.828	-113	0.15	-10	1.6
8.5	0.11	-141	0.83	-119	0.827	-119	0.15	-13	1.6
9.0	0.11	-155	0.83	-126	0.830	-126	0.13	-17	1.6
9.5	0.10	-169	0.83	-133	0.830	-133	0.12	-22	1.6
10.0	0.10	178	0.83	-140	0.832	-140	0.11	-26	1.6
10.5	0.10	167	0.83	-147	0.830	-147	0.10	-29	1.6
11.0	0.11	155	0.83	-154	0.827	-154	0.09	-30	1.7
11.5	0.11	143	0.83	-161	0.825	-161	0.09	-26	1.7
12.0	0.11	135	0.82	-168	0.820	-168	0.08	-27	1.7
12.5	0.11	123	0.82	-175	0.816	-175	0.07	-23	1.7
13.0	0.11	108	0.82	178	0.814	178	0.05	-21	1.8
13.5	0.10	88	0.81	171	0.814	171	0.03	-27	1.8
14.0	0.08	62	0.81	164	0.815	165	0.01	-82	1.8
14.5	0.07	29	0.82	157	0.816	157	0.03	-139	1.8
15.0	0.06	-2	0.81	150	0.809	150	0.05	-153	1.8
15.5	0.06	-31	0.81	143	0.804	143	0.06	-158	1.9
16.0	0.07	-58	0.80	136	0.798	136	0.07	-163	2.0
16.5	0.08	-79	0.79	129	0.795	129	0.07	-165	2.0
17.0	0.11	-100	0.79	122	0.791	122	0.08	-161	2.1
17.5	0.14	-118	0.78	115	0.782	115	0.11	-160	2.2
18.0	0.17	136	0.77	109	0.770	109	0.13	-158	2.3

$$T_A = 25\text{ }^\circ\text{C}, V^+ = 12\text{ V}, I^+ = 29\text{ mA}$$

Reference planes for S-parameter data include bond wires as specified in the "Recommended Assembly Diagram." The S-parameters are also available on floppy disk and the world wide web.

TYPICAL S-PARAMETERS
 Isolated Path

Frequency (GHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂		Isolation (dB)
	MAG	ANG(°)	MAG	ANG(°)	MAG	ANG(°)	MAG	ANG(°)	
0.5	0.87	179	0.001	33	0.001	44	0.99	-4	60.0
1.0	0.85	171	0.002	33	0.002	40	0.99	-9	54.0
1.5	0.83	165	0.003	23	0.003	29	0.99	-13	50.5
2.0	0.81	159	0.003	13	0.003	18	0.99	-17	50.5
2.5	0.79	155	0.003	3	0.003	7	0.99	-20	50.5
3.0	0.78	150	0.003	-7	0.003	-3	0.99	-23	50.5
3.5	0.77	146	0.003	-17	0.003	-14	0.98	-26	50.5
4.0	0.76	141	0.003	-26	0.003	-23	0.98	-28	50.5
4.5	0.76	137	0.002	-37	0.002	-34	0.98	-30	54.0
5.0	0.75	133	0.002	-50	0.002	-46	0.98	-32	54.0
5.5	0.74	129	0.002	-66	0.002	-62	0.98	-35	54.0
6.0	0.74	125	0.002	-83	0.002	-81	0.98	-39	54.0
6.5	0.73	122	0.002	-105	0.002	-105	0.98	-43	54.0
7.0	0.74	118	0.002	-125	0.002	-125	0.97	-47	54.0
7.5	0.74	114	0.002	-143	0.002	-144	0.97	-50	54.0
8.0	0.74	109	0.002	-157	0.002	-157	0.96	-54	54.0
8.5	0.73	105	0.003	-167	0.002	-167	0.96	-57	50.5
9.0	0.72	101	0.003	-175	0.003	-174	0.97	-61	50.5
9.5	0.72	97	0.003	179	0.003	180	0.97	-66	50.5
10.0	0.72	93	0.003	174	0.004	174	0.97	-71	50.5
10.5	0.71	90	0.004	171	0.004	170	0.96	-75	48.0
11.0	0.72	87	0.004	167	0.004	166	0.95	-80	48.0
11.5	0.73	83	0.004	165	0.004	165	0.94	-83	48.0
12.0	0.71	79	0.005	162	0.004	164	0.94	-87	46.0
12.5	0.70	76	0.005	162	0.004	164	0.94	-92	46.0
13.0	0.69	73	0.005	161	0.005	163	0.95	-98	46.0
13.5	0.69	69	0.005	163	0.005	162	0.94	-105	46.0
14.0	0.69	64	0.005	164	0.006	162	0.93	-112	46.0
14.5	0.70	59	0.006	161	0.006	160	0.92	-117	44.4
15.0	0.70	53	0.006	159	0.006	159	0.90	-121	44.4
15.5	0.69	48	0.007	156	0.007	158	0.90	-125	43.1
16.0	0.66	43	0.007	146	0.007	150	0.90	-129	43.1
16.5	0.64	40	0.007	142	0.007	144	0.91	-133	43.1
17.0	0.63	36	0.006	136	0.006	135	0.91	-138	44.4
17.5	0.62	33	0.004	148	0.004	146	0.90	-143	48.0
18.0	0.61	31	0.006	167	0.006	166	0.87	-145	44.4

$$T_A = 25\text{ }^\circ\text{C}, V^+ = 12\text{ V}, I^+ = 29\text{ mA}$$

Reference planes for S-parameter data include bond wires as specified in the "Recommended Assembly Diagram". The S-parameters are also available on floppy disk and the world wide web.

RF CHARACTERISTICS

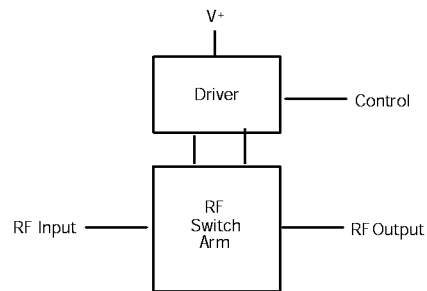
PARAMETER		TEST CONDITIONS	TYP	UNIT
IL	Insertion loss	f = DC to 10 GHz	1.65	dB
		f = 10 to 18 GHz	2.25	
SWR (in)	Input standing wave ratio	f = DC to 10 GHz	1.3:1	-
		f = 10 to 18 GHz	1.5:1	
SWR (out)	Output standing wave ratio	f = DC to 18 GHz	1.5:1	
ISO	Isolation	f = DC to 18 GHz	43.0	dB
P1dB(in)	Input power at 1-dB gain compression	f = DC to 2 GHz	16	dBm
		f = 2 to 18 GHz	26.5	
t _d	Delay time, 50% open-collector TTL input to 90% (10%) RF output		8	ns
t _r	Rise time, 10% RF output to 90% RF output		6	ns
t _f	Fall time, 90% RF output to 10% RF output		6	ns
V _{OH}	High-level inverting output voltage		5.5	V
V _{OL}	Low-level inverting output voltage		0.6	V
	Inverting output current source/sink capability		2	mA

$$V^+ = 12 \text{ V}, I^+ = 29 \text{ mA}, T_A = 25 \text{ }^\circ\text{C}$$

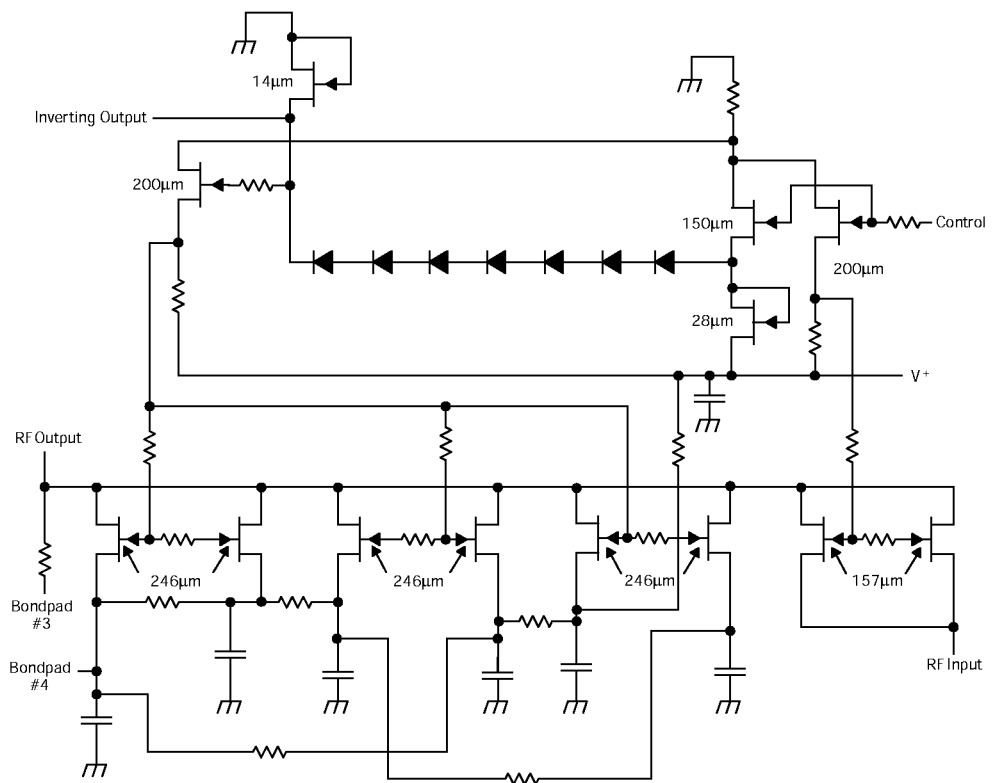
DC CHARACTERISTICS

PARAMETER	MIN	TYP	MAX	UNIT
Supply voltage, V ⁺	11	12	14	V
High-level control input voltage, V _{IH}	4.5	5	6	V
Low-level control input voltage, V _{IL}	0	0	0.5	V

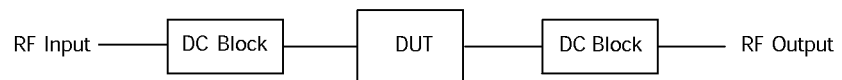
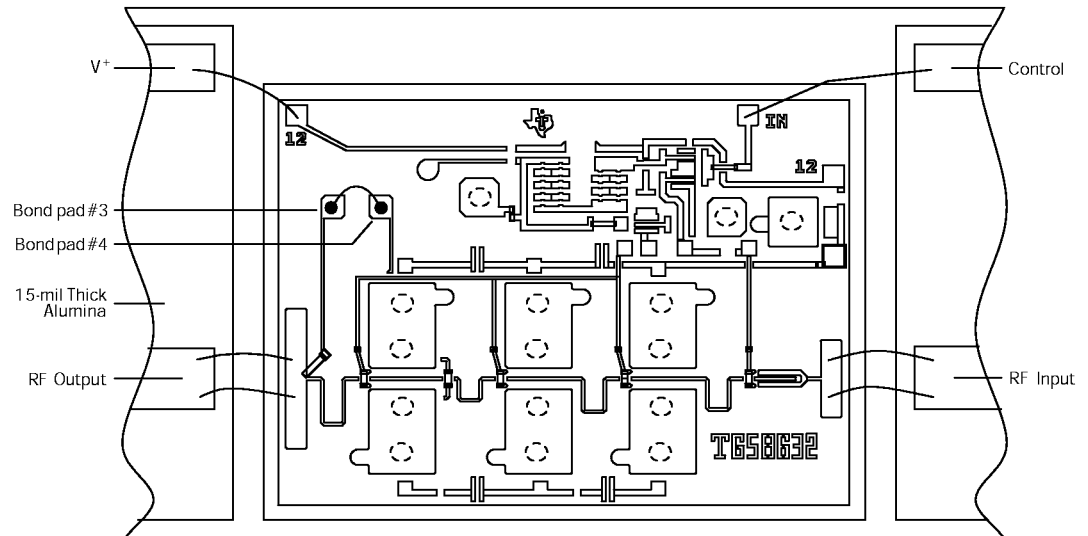
**FUNCTIONAL
BLOCK DIAGRAM**



EQUIVALENT SCHEMATIC



RF ports are not DC-isolated.

**RECOMMENDED
TEST CONFIGURATION****RECOMMENDED
ASSEMBLY DIAGRAM**

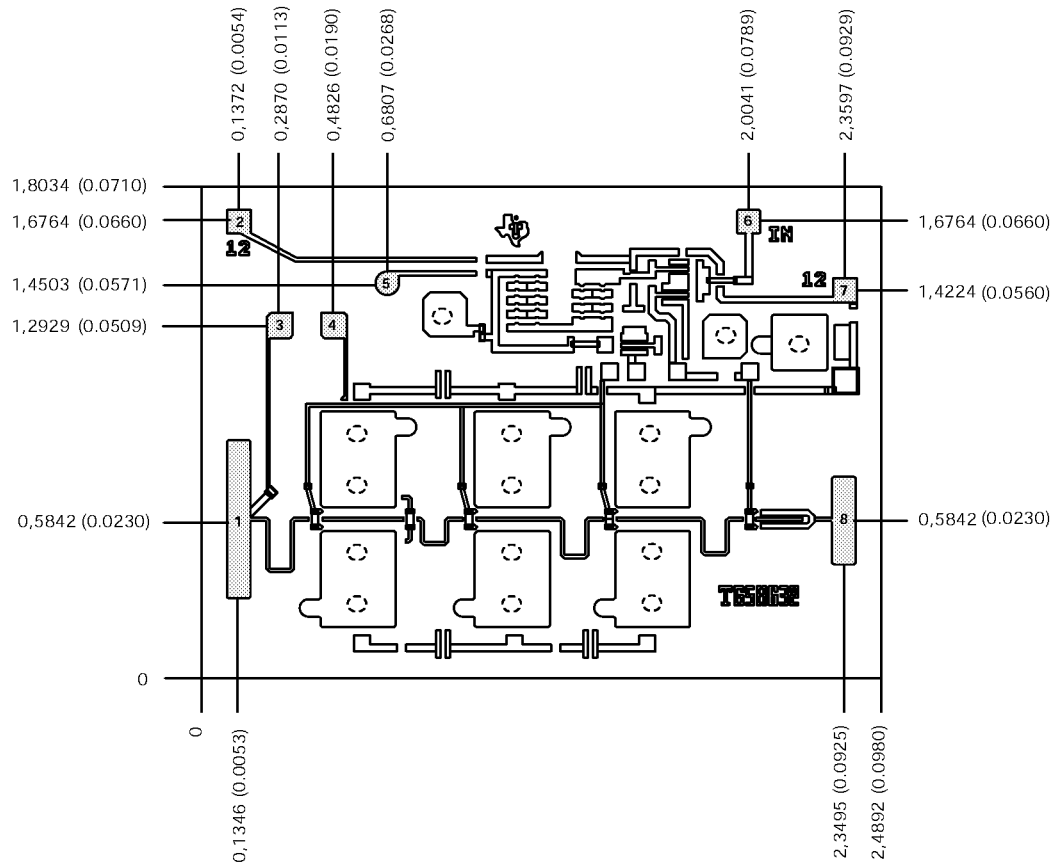
RF connections: Bond using two 1-mil diameter, 20 to 25-mil-length gold bond wires at both RF Input and RF Output ports for optimum RF performance.

Bond pads 3 and 4 must be bonded together for proper operation.

Low-loss path from RF Input to RF Output for $V_{\text{CONTROL}} = 0 \text{ V}$. Isolated path from RF Input to RF Output for $V_{\text{control}} = 5 \text{ V}$.

RF isolation will be limited by the chip operating environment.

MECHANICAL DRAWING



Millimeters (inches)

Thickness: 0,102 (0.004) (reference only)

Chip edge to bond pad dimensions are shown to center of bond pad.

Chip size \pm 0,0508 (0.002)

Bond pad #1 (RF In):	0,0965 x 0,5867 (0.0038 x 0.0231)
Bond pad #2 (V ⁺):	0,0965 x 0,0965 (0.0038 x 0.0038)
Bond pad #3:	0,1016 x 0,1016 (0.0040 x 0.0040)
Bond pad #4:	0,1016 x 0,1016 (0.0040 x 0.0040)
Bond pad #5 (Inverting Output):	0,0965 (0.0038) diameter
Bond pad #6 (CONTROL):	0,0965 x 0,0965 (0.0038 x 0.0038)
Bond pad #7 (V ⁺):	0,0991 x 0,0991 (0.0039 x 0.0039)
Bond pad #8 (RF Out):	0,0965 x 0,3302 (0.0038 x 0.0130)

Bond pad #2 and bond pad #7 are internally connected. Connect only one of these to a positive voltage supply.



This device is susceptible to damage from electric discharge. Handling and packaging of this device and/or assembly should be accomplished only with adequate provisions to prevent electrostatic discharge damage. IMPORTANT NOTICE: Export of this controlled commodity requires appropriate export license authority from the U.S. Government. © Copyright 1996. Texas Instruments Incorporated. All rights reserved.